

# The STAR Silicon Strip Detector (SSD)

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## Abstract

The STAR Silicon Strip Detector (SSD) completes the three layers of the Silicon Vertex Tracker (SVT) to make an inner tracking system located inside the Time Projection Chamber (TPC). This additional fourth layer provides two dimensional hit position and energy loss measurements for charged particles, improving the extrapolation of TPC tracks through SVT hits. To match the high multiplicity of central Au+Au collisions at RHIC the double sided silicon strip technology was chosen which makes the SSD a half million channels detector. Dedicated electronics have been designed for both readout and control. Also a novel technique of bonding, the Tape Automated Bonding (TAB), was used to fulfill the large number of bonds to be done. All aspects of the SSD are shortly described here and test performances of produced detection modules as well as simulated results on hit reconstruction are given.

## 1 Introduction

The STAR Silicon Strip Detector (SSD) [1] constitutes the fourth layer of the inner tracking system. Installed between the Silicon Vertex Tracker (SVT) and the Time Projection Chamber (TPC), the SSD will enhance the tracking

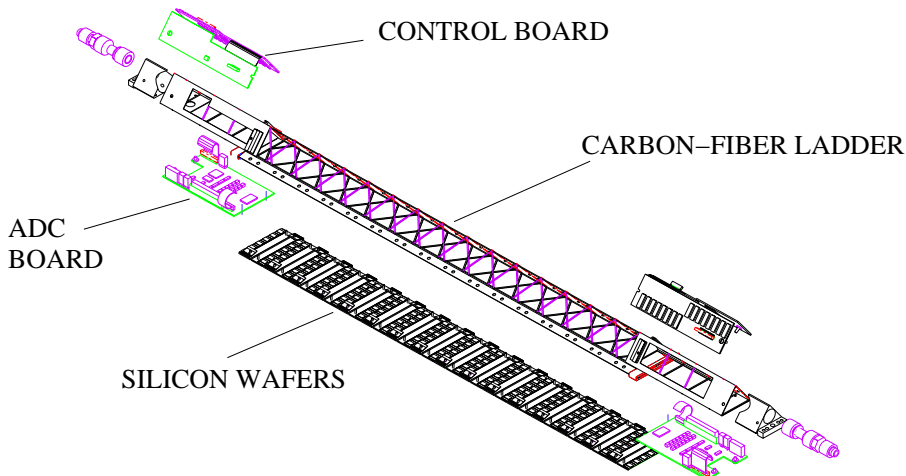


Fig. 1. An SSD ladder showing separately its components.

capabilities of the STAR experiment by measuring accurately the two dimensional hit position and energy loss of charged particles. It aims specifically at improving the extrapolation of TPC tracks through SVT hits and increasing the average number of space points measured near the collision thus increasing the detection efficiency of long-lived meta-stable particles.

The SSD is placed at a distance of 230 mm from the beam axis, covering a pseudo-rapidity range of  $|\eta| < 1.2$  which leads to a total silicon surface close to  $1 \text{ m}^2$ .

The design of the SSD is based on two clamshells, each containing 10 carbon-fiber ladders. Each ladder (figure 1) supports 16 wafers using double-sided silicon strip technology (768 strips per side) and connected to the front-end electronics (6 ALICE 128C chips per side) by means of the Tape Automated Bonded (TAB) technology [2]. The ladders are tilted with respect to their long axis, allowing the overlap of the detectors in the transverse plane for better hermiticity and alignment performances. A bus cable transports the analog signals along the ladder to two 10 bits ADC boards installed at both ends. After digitization, the signals are sent to Readout Boards which are linked to the DAQ system through Giga-link optics fibers. the whole system is remotely controlled to monitor powers and temperature but also to calibrate and tune the front-end electronics. The cooling system is based on an air-flow through the ladder which is embedded in a mylar sheet.

## 2 Mechanics

The mechanical design is constrained by : 1) the inner radius of the TPC (including a safety margin in order to avoid any distortion of the TPC field) and the rods connecting the two cones supporting the SVT; 2) limited material budget; 3) stability with respect to temperature variations and minimization of the sagging due the weight of the modules in order to insure good alignment precision. Each ladder is 1060 mm long, featuring a triangular cross-section of 40 mm base. The ladders are made of high-modulus carbon-fiber which allows for both a good rigidity and a low material budget. The sagitta of a loaded ladder has been estimated by simulation to be lower than 10  $\mu\text{m}$ . The SSD modules are glued on the carbon ladder by an elastic epoxy glue in order to accommodate the different thermal expansion coefficients of silicon and carbon. Two sets of ten ladders are assembled on C-shaped ribs which allow for installation on the common SVT/SSD support structure.

## 3 Wafers

The design of the silicon wafers was inspired by the initial design of the ALICE experiment silicon strip detector [4]. The wafers are 75 mm by 42 mm sized and 300  $\mu\text{m}$  thick. The strips are oriented perpendicularly with respect to the longest dimension of the detector on both sides (double-sided technology), with a pitch of 95  $\mu\text{m}$  (768 strips per side). The insulation between strips on the N side is achieved by p-spraying, and the biasing scheme uses punch-through technics. The bias ring surrounded by a guard ring define an active area of 73 mm by 40 mm. The strips on the P and N sides are inclined by 35 mrad with respect to each other and symmetrically with respect to the wafer edge. Combined with the charge correlation due to the double-sided technology, this stereo angle allows an efficient 2-dimension impact point reconstruction in a high multiplicity environment with a low ambiguity yield [5]. The pitch is chosen in order to achieve a minimum resolution (digital resolution) of 30  $\mu\text{m}$  in the transverse plane and 800 $\mu\text{m}$  along the Z axis. During production, all the 440 produced detectors have been fully characterized with a probe-station allowing the measurement of their depletion voltage and leakage current (figure 2). The detectors can currently be operated between 20 V and 50 V. Moreover, the corresponding 680000 strips have been scanned to identify every defective strips [10]. A very low average number of dead strips have been measured, well below 1%, see figure ?? . Prototypes were irradiated in order to test their capability to cope with the expected fluxes [7].

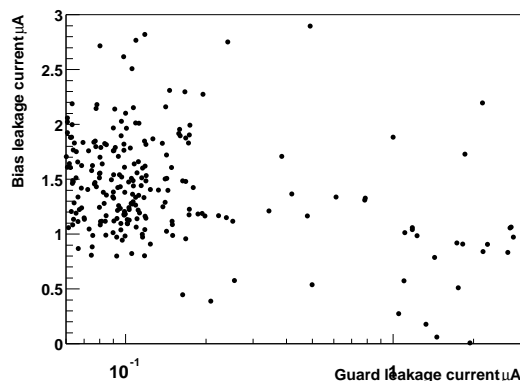


Fig. 2. Distribution of the leakage current of the bias ring with respect to the leakage current of the guard ring of the wafers.

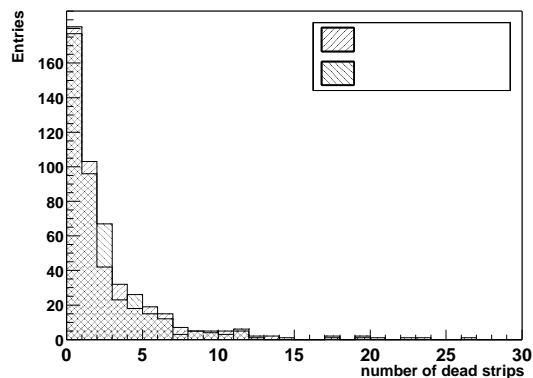


Fig. 3. Distribution of the number of dead strips identified per side of the wafers.

#### 4 Front-end electronics and modules

Each of the 320 detection modules (figure 4) is composed of a silicon wafer, two hybrid circuits (one per side) supporting the front-end electronics and a mechanical structure [3]. The front-end electronics is constituted by six ALICE 128C chips per side [8]. The ALICE 128C is a low power consumption chip, specially designed for the STAR and ALICE silicon strip detectors using the AMS 1.2  $\mu\text{m}$  CMOS technology. Each of the 128 analog input channels of the chips allows the amplification, shaping and storage of the charge collected on a single strip. The shaping time is adjustable between 1.2 and 2  $\mu\text{s}$ , the dynamic range extends up to  $\pm 13$  MIPs with a nominal noise of  $290 e + 8 e/pF$ . An analog multiplexer allows the sequential readout of the data at a rate up to 10 MHz. The chip is controlled through JTAG protocol in order to tune and monitor remotely its performances. The front-end electronics is supported by a hybrid circuit which is a copper printed kapton tape glued on a

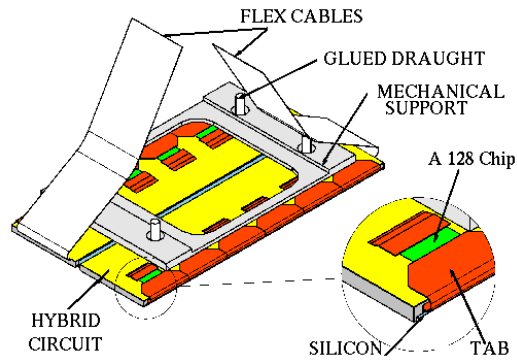


Fig. 4. Schematic view of an SSD module with its components.

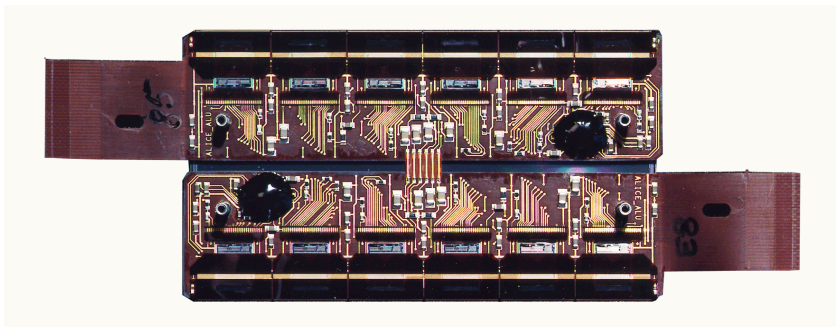


Fig. 5. Photo of an assembled module viewed from the hybrid side.

carbon stiffener. The main components on the hybrids are ALICE128C chips and a COSTAR (CONTROL STAR) chip [9] designed for slow control purposes : temperature and leakage current measurements as well as pedestal compensation. Tape Automated Bonding (TAB) is used for the connection between the strips on the detector and the analog inputs of the ALICE 128C chips [12]. This bumpless technology is based on a kapton microcable on which are printed copper strips, the flexibility of the cable allowing the folding of the hybrids on top of the detector in order to make the detection module very compact, see figure 5. Furthermore, this cable plays the role of a pitch adaptor between the  $95\ \mu\text{m}$  pitch of the detector and the  $44\ \mu\text{m}$  pitch of chips on the hybrid. The TAB technology is also applied for the connection between the chip and the hybrid (control signals, power supplies, analog output...). During the production stage, the chip is first connected to a TAB tape and then fully tested (biasing parameters, dead channels) [10] before its connection to the detector. An internal pulse generator allows for the independent test of any channel at any time of the assembly process and once the detector is installed in STAR. After the assembly of modules, each strip is calibrated with a dedicated laser test bench.

## 5 Readout electronics

A kapton cable connects the hybrid to a Control Board which takes care of the JTAG communication and of the protection against latchup in the chips. The analog signals are transferred from the Control Board to the ADC Board, both located at the end of the ladder (one set per side and per ladder). The ADC board reads sequentially the data of a full ladder at 10 MHz. The analog signal (50 mV/MiP) are converted over 10 bits for a range of 1 V. The Control Board is sliced in two parts connected through a flexible cable in order to be folded at the ladder edges, each board being aligned with one of the side of the triangular shape of the carbon ladder. The Control Board is connected to the ADC Board which is installed at the bottom edge of the ladder. The interface between the detector (ADC, JTAG control of the chips) and the STAR system (DAQ, Slow-control, trigger) is done through four Readout Boards located on the TPC wheels. All the functionalities of the Readout Board are performed by an FPGA programable chip. The system is able to read the full channels in less than 5 ms.

## 6 Performances

The most relevant characteristics of the SSD are spatial resolution and detection efficiency. The first is driven by the pitch, the diffusion of the charge cloud in the the wafer bulk, the signal to noise ratios and alignment accuracy. The efficiency is determined by the fraction of dead strips on the detector and dead channels on the ALICE 128C chips, the performance of the connection between the detector and the front end electronics and signal-to-noise ratios. Prototypes of the detection modules, as well as of the Control and ADC boards were tested off- and in-beam at CERN. Figure 6 shows typical signal-to-noise ratios obtained from in-beam tests. The spatial resolutions were deduced from the beam-test data by reconstructing impact points associating both sides information. The values are around 15  $\mu\text{m}$  in the  $r/\phi$  direction ( figure 7) and 750  $\mu\text{m}$  in the direction along the strips (corresponding to the beam axis in STAR)[11]. These spatial resolutions are driven by the intrinsic resolution on each side, which are typically of 20  $\mu\text{m}$  and the stereo angle. Due to the quality of the selected detectors, chips and to the TAB connection, one can expect a level of dead channels below 2% in average. This quality is achieved through full tests of all the components at all stages of the production and assembly phases : detector, chip, hybrid, module, ladder, clamshell. All information collected during these tests is stored in a database<sup>1</sup> which may be accessed at any time and from anywhere[13]. This database system provides then syn-

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<sup>1</sup> [www.star-sbg.in2p3.fr](http://www.star-sbg.in2p3.fr)

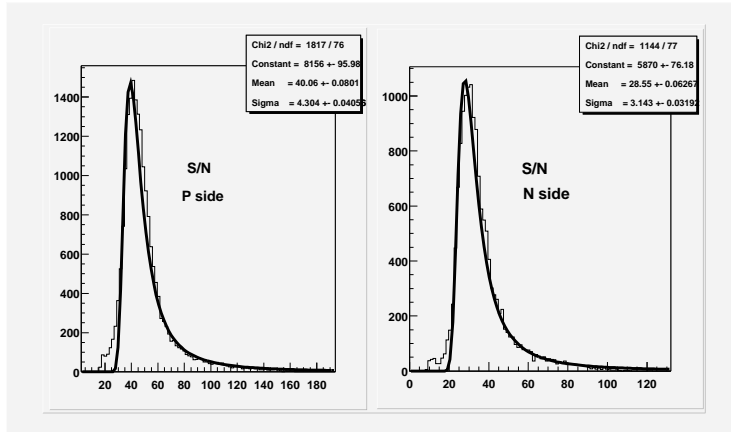


Fig. 6. Typical signal-to-noise distributions obtained with SSD prototypes.

thetical information for monitoring the production, selecting elements for the assembly and eventually checking the status of the whole detector.

A detailed simulation of the detector as well as a hit reconstruction algorithm have been developed to evaluate the global performances of the SSD [6]. The method uses the matching of charges collected on both side of the detector for the same particle to solve ambiguous situation where several particle hits are close together. In nominal conditions for the noise and the number of dead channels the hit reconstruction reaches 95 % of efficiency for 98 % of purity. The evolution of the efficiency with respect to the noise level and the number of dead strips is pictured in figure 8. The general trend is that the efficiency decreases steadily with the average number of dead strips whereas it is much more stable with respect to the noise. The purity is less sensitive to this condition and stay above 98% even for 10% of dead strips or 4 times the nominal noise level.

## 7 Summary

The Silicon Strip Detector for STAR with around 1 m<sup>2</sup> of sensitive surface and half a million channels constitutes one of the largest one-layer apparatus in the doubled sided silicon strip technology, see summary table 1. The difficulty for connecting both sides of the silicon wafers on their front-end electronics was overcome thanks to the use of the novel Tape Automated Bonding method which allows the design of a compact module. Other innovative solutions were used like air flow cooling and full remote control of the front-end electronics to minimize the material budget and to face the large amount of parameters needed to operate the SSD.

In-beam tests of final design detection modules demonstrated that the reso-

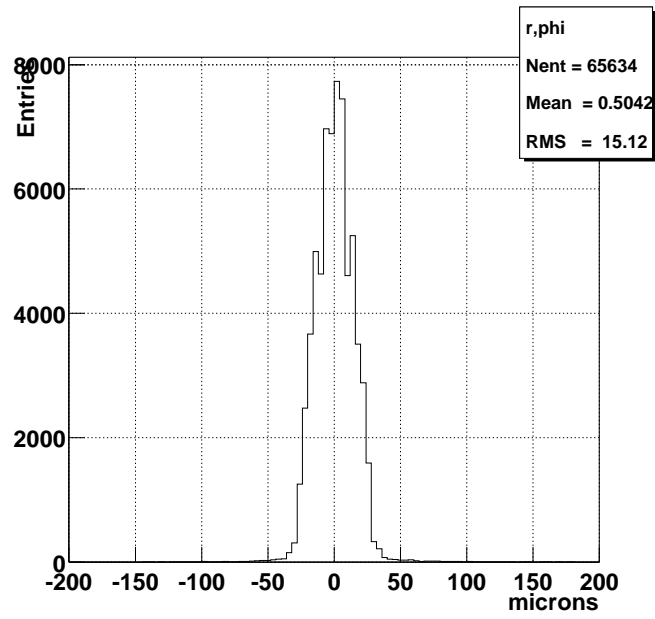


Fig. 7. Distribution of the error on the position of the hit obtained with a detailed simulation of the SSD ( $r/\phi$  direction).

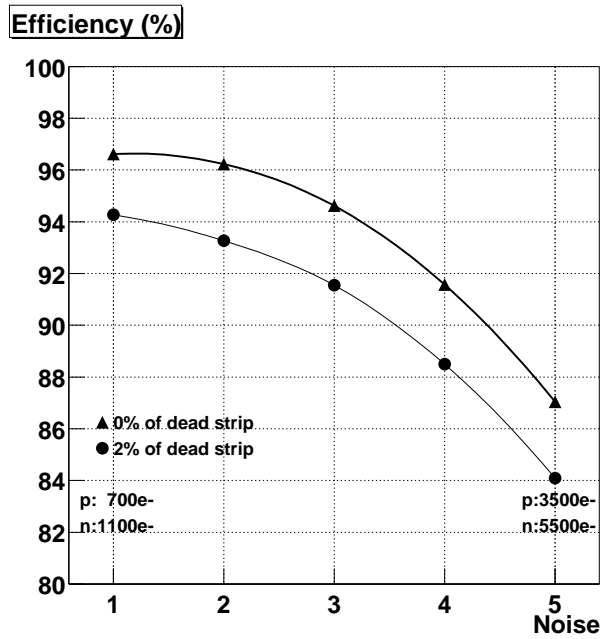


Fig. 8. Variation of the 2-D hit reconstruction efficiency with the noise level of the SSD for two different number of dead strips.



lutions of  $15\mu\text{m}$  in the transverse to beam direction and  $750\mu\text{m}$  in the beam direction was indeed achievable. A full simulation with realistic noise and dead channel conditions was performed and yielded a 95 % efficiency-98 % purity for hit reconstruction.

The detector is currently in production phase and will be installed in STAR in 2002. Exhaustive testing of all the sensitive pieces are conducted and results are stored in a database for further use during the operation of the detector.

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<b>General layout</b>	
radius	230 mm
ladder length	1060 mm
acceptance	$ \eta  < 1.2$
# of ladders	20
# of wafers per ladder	16
total # of wafers	320
<b>Silicon wafers characteristics</b>	
# of sides per wafer	2
# of strips per side	768
total readout channels	491520
silicon wafer sensitive area	73 x 40 mm
total silicon surface	0.98 m <sup>2</sup>
wafer pitch	95 $\mu$ m
$r\phi$ resolution	20 $\mu$ m
z resolution	740 $\mu$ m
operating voltage	20 $\div$ 50 V
leakage current for one wafer	1 $\div$ 2 $\mu$ A
<b>Readout front-end electronics</b>	
# of input channels per circuits	128
total # of circuits	3840
dynamical range	$\pm 13$ MIPs
shaping time	1.2 $\div$ 2 $\mu$ s
Signal / Noise	30 $\div$ 50
SSD total readout time	< 5 ms
<b>Expected performances</b>	
dead channels level	$\sim 2\%$
hit reconstruction efficiency	$\sim 95\%$
hit reconstruction purity	$\sim 98\%$

Table 1  
Summary of the SSD characteristics and performances.

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